

IN-PLACE CRYSTAL LATTICE	2.506	2.498	Ni Ni:Al =1:1
LATTICE PLANE PARALLEL TO THE SUBSTRATE SURFACE (ORIENTATIONAL PLANE)	(10.0)	(211)	(211)
CRYSTAL STRUCTURE	disi'y	Pic.	
	MAGNETIC LAYER Co a=2.506 Å c=4.078 Å	UNDER LAYER Cr a=2.884 Å	ORIENTATION CONTROL LAYER HAVING B2 TYPE CRYSTAL STRUCTURE NIAI50 a=2.881 Å

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FIG. 3

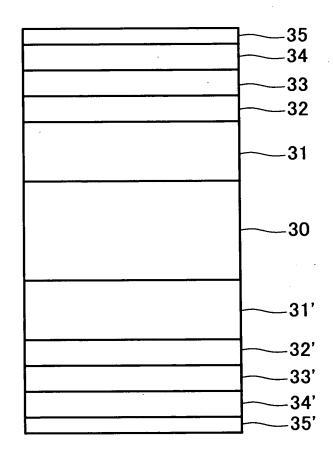
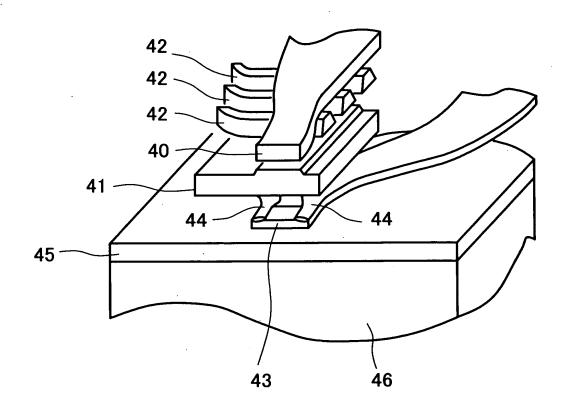
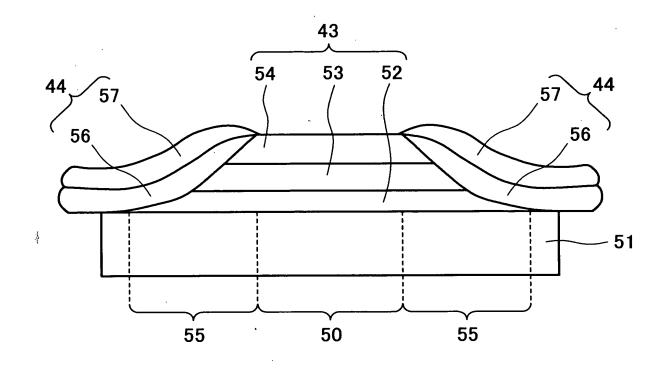


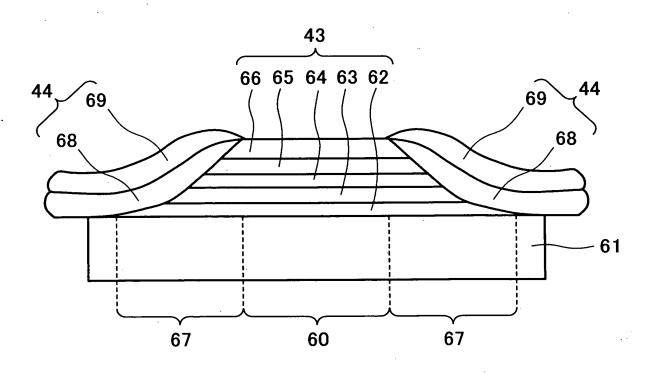
FIG. 4











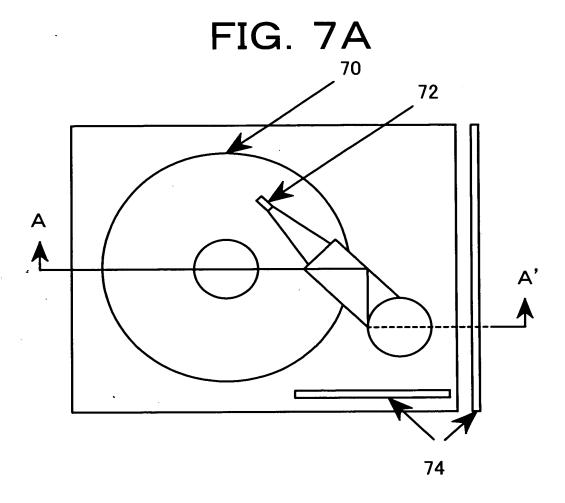
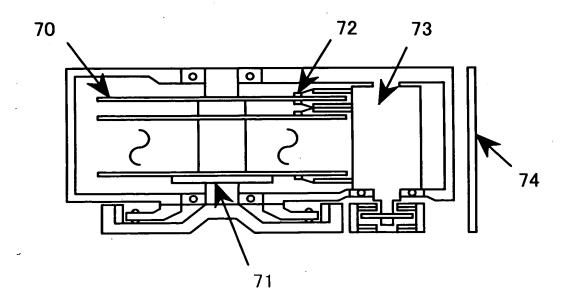


FIG. 7B





	Hc[kOe]	s*	MEDIA NOISE
EXAMPLE 1	3.8	0.85	1.0
COMPARISON 1	3.0	0.70	2.0

FIG. 9

		C_o C_r P_t (10,0) DIFFRACTION INTENSITY BY XRD (RELATIVE ITENSITY)
_	EXAMPLE 1	1.0
	COMPARISON 1	0.7



	Hc[kOe]	s*	MEDIA NOISE
EXAMPLE 2	3.8	0.85	1.0
COMPARISON 2	3.0	0.70	2.0

·	C_o C_r P_t (10,0) DIFFRACTION INTENSITY BY XRD (RELATIVE ITENSITY)
EXAMPLE 2	1.0
COMPARISON 2	0.7



CRYSTAL STRUCTURE ··· L2₁

TARGET ···NiAl₂₅Ti₂₅ (a=5.87 Å)

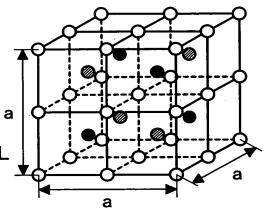
NUMBER OF ATOMS IN UNIT CELL

Ni ATOM: 8 Al ATOM: 4

Ti ATOM: 4

·COMPOSITION IN UNIT CELL

Ni:AI:Ti=2:1:1

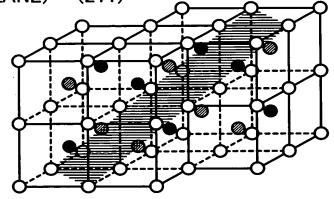


LATTICE PLANE PARALLEL TO THE SUBSTRATE SURFACE (ORIENTATIONAL PLANE)...(211)

O Ni ATOM

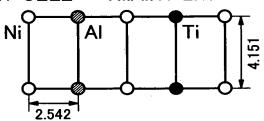
O Al ATOM

Ti ATOM



IN-PLACE CRYSTAL LATTICE

COMPOSITION IN UNIT CELL ··· Ni:AI:Ti=2:1:1







	Hc[kOe]	s*	MEDIA NOISE
EXAMPLE 3	3.5	0.80	1.0
COMPARISON 3	3.0	0.70	1.7

FIG. 14

	C _o C _r P _t (10,0) DIFFRACTION INTENSITY BY XRD (RELATIVE ITENSITY)
EXAMPLE 3	1.0
COMPARISON 3	0.7





CRYSTAL STRUCTURE	LATTICE PLANE PARALLEL TO THE SUBSTRATE SURFACE (ORIENTATIONAL PLANE)	IN-PLACE CRYSTAL LATTICE
f.c.c. STRUCTURE Au a=4.078 Å	(110)	(a√2/2)

ELEMENT	аÅ	a√2/2 [Å]
Al	4.051	2.864
Cu	3.615	2.556
Rh	3.803	2.689
Pd	3.890	2.751
Ag	4.086	2.889
, Ir	3.839	2.715
Pt	3.923	2.774
At	4.078	2.884





	Hc[kOe]	s*	MEDIA NOISE
EXAMPLE 4	3.2	0.80	1.0
COMPARISON 4	3.0	0.70	2.0

·	C_o C_r P_t (10,0) DIFFRACTION INTENSITY BY XRD (RELATIVE ITENSITY)	
EXAMPLE 4	1.0	
COMPARISON 4	0.8	





FIG. 18

